## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10575347	KIM ET AL.
Examiner	Art Unit
Jennifer F Hu	4158

SEARCHED					
Class	Subclass	Date	Examiner		
343	702	11/14/2007	Jennifer F.		
			Chang		
343	700MS, 770, 846	4/17/2009	JH		

SEARCH NOTES			
Search Notes	Date	Examiner	
EAST Search History	11/14/2007	Jennifer F. Chang	
Inventor Search in eDAN	11/14/2007	Jennifer F. Chang	
EAST Search History	4/21/2009	JH	

INTERFERENCE SEARCH				
Class		Subclass	Date	Examiner
343	702		4/21/2009	JH

/JENNIFER F HU/ Examiner.Art Unit 2821	